

Description

The HSI1553CDLT1GE3 uses advanced trench technologyto provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

S2 D1 D1 G1 S1

SOT-363 (SC-70-6)

General Features

 $V_{DS} = 20V I_D = 0.75A$

 $R_{DS(ON)}$ < 380m Ω @ V_{GS} =4.5V

 $V_{DS} = -20V I_{D} = -0.66A$

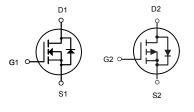
 $R_{DS(ON)}$ < 570 m Ω @ V_{GS} =-4.5V

Application

Wireless charging

Boost driver

Brushless motor



N-Channel MOSFET

P-Channel MOSFE

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
HSI1553CDLT1GE3	SOT-363(SC-70-6)		3000

Absolute Maximum Ratings (T_c=25℃unless otherwise noted)

Symbol	Bt	Rati	11	
	Parameter	N-Channel	P-Channel	Units
VDS	Drain-Source Voltage	20	-20	V
VGS	Gate-Source Voltage	±12	±12	V
I _D @T _A =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	0.75	-0.66	Α
IDM	Pulsed Drain Current ²	1.8	-1.2	Α
TSTG	Storage Temperature Range	-55 to 150	-55 to 150	$^{\circ}\!\mathbb{C}$
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	$^{\circ}$
R _θ JA	Thermal Resistance Junction-Ambient ¹	833		°C/W

N-ch MOSFET ELECTRICAL CHARACTERISTICS(T_a=25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
STATIC CHARACTERISTICS							
Drain-source breakdown voltage	V _{(BR)DSS}	Vgs = 0V, ID =250µA	20			V	
Zero gate voltage drain current	IDSS	Vps =20V,Vgs = 0V			1	μΑ	
Gate-body leakage current	Igss	Vgs =±10V, Vps = 0V			±20	uA	
Gate threshold voltage (note 2)	VGS(th)	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	0.35		1.1	V	
Drain source on registence(note 2)	RDS(on)	Vgs =4.5V, ID =0.65A		210	380	mΩ	
Drain-source on-resistance(note 2)		Vgs =2.5V, ID =0.55A		320	450	mΩ	
		Vgs =1.8V, ID =0.45A		390	800	mΩ	
Forward tranconductance(note 2)	grs	Vps =10V, Ip =0.8A		1.6		S	
Diode forward voltage	V_{SD}	I _S =0.15A, V _G S = 0V			1.2	V	
DYNAMIC CHARACTERISTICS (note 4)							
Input Capacitance	C _{iss}			79	120	pF	
Output Capacitance	Coss	Vps =16V,Vgs =0V,f =1MHz		13	20	pF	
Reverse Transfer Capacitance	Crss			9	15	pF	
SWITCHING CHARACTERISTICS (note 3,4)							
Turn-on delay time	td(on)			6.7		ns	
Turn-on rise time	tr	V _{GS} =4.5V,V _{DS} =10V,		4.8		ns	
Turn-off delay time	td(off)	$I_D=500mA,R_{GEN}=10\Omega$		17.3		ns	
Turn-off fall time	tr			7.4		ns	

P-ch MOSFET ELECTRICAL CHARACTERISTICS(T_a=25℃ unless otherwise noted)

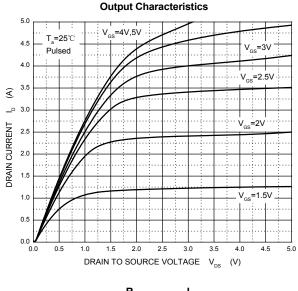
Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
STATIC CHARACTERISTICS							
Drain-source breakdown voltage	V(BR)DSS	Vgs = 0V, Ip =-250μA -20				V	
Zero gate voltage drain current	IDSS	Vps =-20V,Vgs = 0V	DS =-20V,VGS = 0V		-1	μΑ	
Gate-body leakage current	Igss	Vgs =±10V, Vps = 0V			±20	uA	
Gate threshold voltage (note 2)	VGS(th)	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$	-0.35		-1.1	V	
Duning any and any and any and any	RDS(on)	Vgs =-4.5V, Ip =-1A		430	570	mΩ	
Drain-source on-resistance(note 2)		Vgs =-2.5V, ID =-0.8A		624	700	mΩ	
		Vgs =-1.8V, Ip =-0.5A		950		mΩ	
Forward tranconductance(note 2)	g FS	Vps =-10V, Ip =-0.54A		1.2		S	
Diode forward voltage	V _{SD}	I _S =-0.5A, V _G S = 0V			-1.2	V	
DYNAMIC CHARACTERISTICS (note 4)							
Input Capacitance	Ciss			113	170	рF	
Output Capacitance	Coss	Vps =-16V,Vgs =0V,f =1MHz		15	25	pF	
Reverse Transfer Capacitance	C _{rss}			9	15	pF	
SWITCHING CHARACTERISTICS (note 3, 4)							
Turn-on delay time	td(on)			9		ns	
Turn-on rise time	tr	V _{GS} =-4.5V,V _{DS} =-10V,		5.8		ns	
Turn-off delay time	td(off)	I_D =-200mA, R_{GEN} =10 Ω		32.7		ns	
Turn-off fall time	tr			20.3		ns	

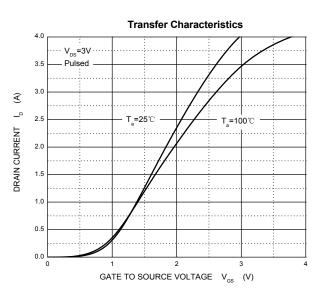
Notes:

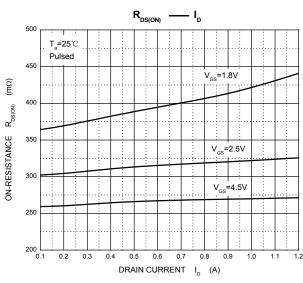
- 1. Surface mounted on FR4 board using the minimum recommended pad size.
- 2. Pulse Test : Pulse width=300µs, duty cycle≤2%.
- 3. Switching characteristics are independent of operating junction temperature.
- 4. Graranted by design, not subject to producting.

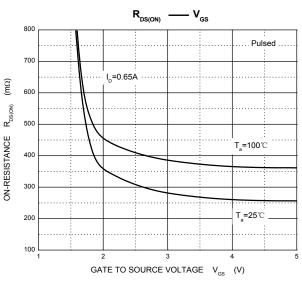


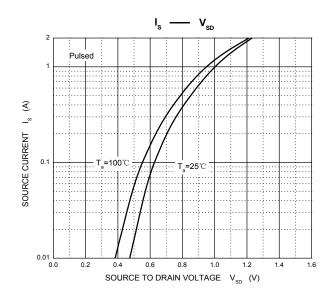
N-Channel Typical Characteristics

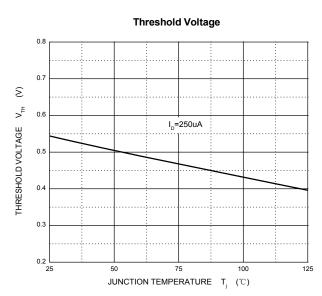






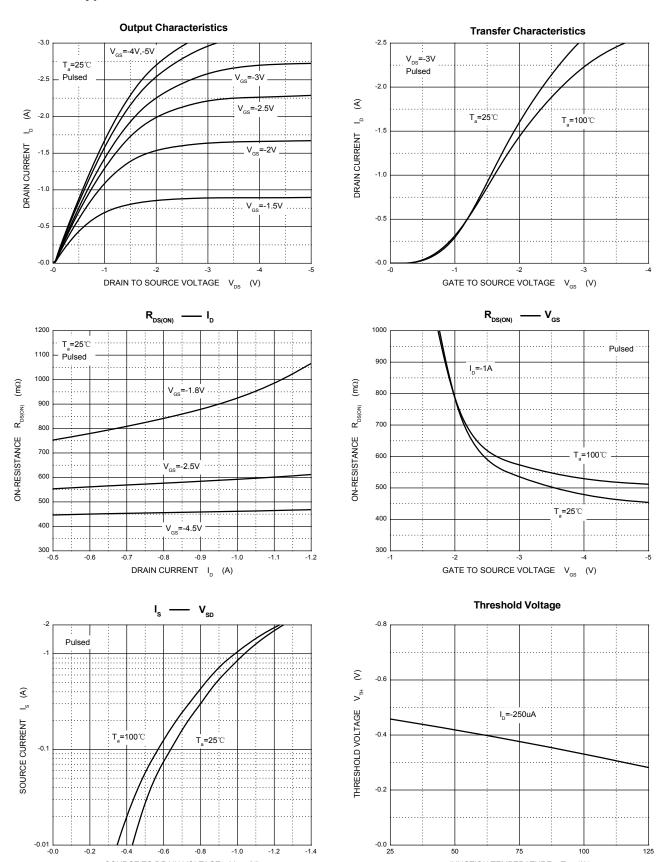








P-Channel Typical Characteristics

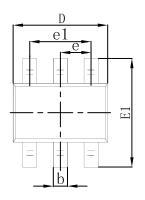


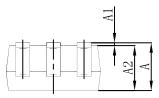
SOURCE TO DRAIN VOLTAGE V_{SD} (V)

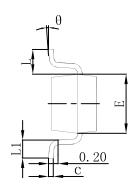
JUNCTION TEMPERATURE T_{ij} (°C)



SOT-363(SC-70-6) Package Outline Dimensions

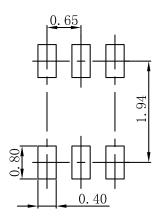






Symbol	Dimensions	In Millimeters	Dimensions In Inches		
	Min	Max	Min	Max	
Α	0.900	1.100	0.035	0.043	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.000	0.035	0.039	
b	0.150	0.350	0.006	0.014	
С	0.100	0.150	0.004	0.006	
D	2.000	2.200	0.079	0.087	
E	1.150	1.350	0.045	0.053	
E1	2.150	2.400	0.085	0.094	
е	0.650 TYP		0.026	S TYP	
e1	1.200	1.400	0.047	0.055	
L	0.525 REF		0.021 REF		
L1	0.260	0.460	0.010	0.018	
θ	0°	8°	0°	8°	

SOT-363(SC-70-6) Suggested Pad Layout



Note:

- 1. Controlling dimension: in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

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